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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
		Darryl D. DesMarteau, "NOVEL PERFLUORINATED IONOMERS AND IONENES," Journal of Fluorine Chemistry 72,						
	AW	1995, pgs. 203-208						
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*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in								
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